

N-channel 600 V, 0.078  $\Omega$  typ., 34 A MDmesh M2 Power MOSFETs in TO-220FP, I<sup>2</sup>PAKFP and TO-3PF packages

Datasheet – production data

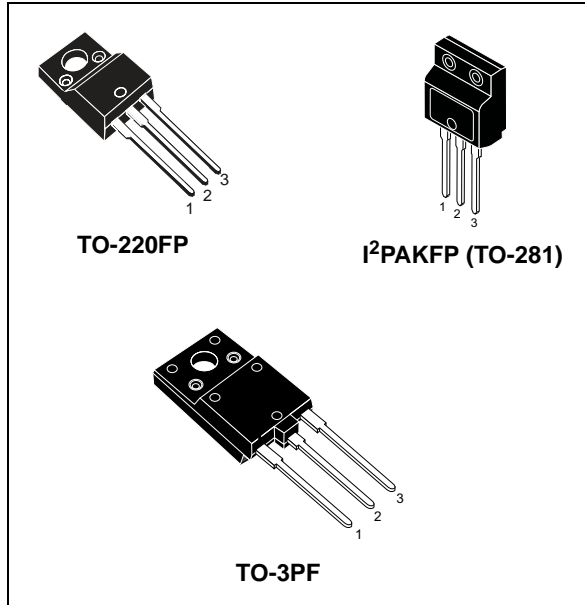
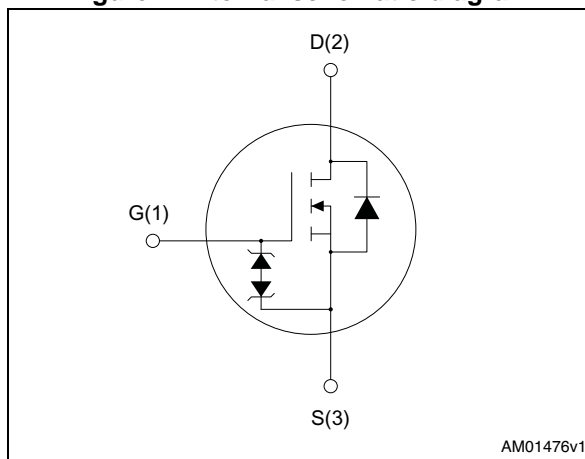


Figure 1. Internal schematic diagram



## Features

| Order codes | V <sub>DS</sub> @ T <sub>Jmax</sub> | R <sub>DS(on)</sub> max | I <sub>D</sub> |
|-------------|-------------------------------------|-------------------------|----------------|
| STF40N60M2  | 650 V                               | 0.088 $\Omega$          | 34 A           |
| STFI40N60M2 |                                     |                         |                |
| STFW40N60M2 |                                     |                         |                |

- Extremely low gate charge
- Excellent output capacitance (C<sub>oss</sub>) profile
- 100% avalanche tested
- Zener-protected

## Applications

- Switching applications
- LLC converters, resonant converters

## Description

These devices are N-channel Power MOSFETs developed using MDmesh™ M2 technology. Thanks to their strip layout and improved vertical structure, the devices exhibit low on-resistance and optimized switching characteristics, rendering them suitable for the most demanding high efficiency converters.

Table 1. Device summary

| Order code  | Marking | Packages                      | Packing |
|-------------|---------|-------------------------------|---------|
| STF40N60M2  | 40N60M2 | TO-220FP                      | Tube    |
| STFI40N60M2 |         | I <sup>2</sup> PAKFP (TO-281) |         |
| STFW40N60M2 |         | TO-3PF                        |         |

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# 1 Electrical ratings

**Table 2. Absolute maximum ratings**

| Symbol                             | Parameter  | Value                             |        | Unit |
|------------------------------------|--|-----------------------------------|--------|------|
|                                    |  | TO-220FP,<br>I <sup>2</sup> PAKFP | TO-3PF |      |
| V <sub>GS</sub>                    | Gate-source voltage  | ± 25                              |        | V    |
| I <sub>D</sub> <sup>(1)</sup>      | Drain current (continuous) at T <sub>C</sub> = 25 °C   | 34                                |        | A    |
| I <sub>D</sub> <sup>(1)</sup>      | Drain current (continuous) at T <sub>C</sub> = 100 °C  | 22                                |        | A    |
| I <sub>DM</sub> <sup>(1),(2)</sup> | Drain current (pulsed)   | 136                               |        | A    |
| P <sub>TOT</sub>                   | Total dissipation at T <sub>C</sub> = 25 °C  | 40                                | 63     | W    |
| dv/dt <sup>(3)</sup>               | Peak diode recovery voltage slope  | 15                                |        | V/ns |
| dv/dt <sup>(4)</sup>               | MOSFET dv/dt ruggedness  | 50                                |        | V/ns |
| V <sub>ISO</sub>                   | Insulation withstand voltage (RMS) from all three leads to external heat sink (t=1 s; T <sub>C</sub> =25 °C) | 2500                              | 3500   | V    |
| T <sub>stg</sub>                   | Storage temperature range  | - 55 to 150                       |        | °C   |
| T <sub>j</sub>                     | Operating junction temperature range   |                                   |        | °C   |

- Limited by maximum junction temperature
- Pulse width limited by safe operating area.
- I<sub>SD</sub> ≤ 34 A, di/dt ≤ 400 A/μs; V<sub>DS peak</sub> < V<sub>(BR)DSS</sub>; V<sub>DD</sub>=400 V.
- V<sub>DS</sub> ≤ 480 V

**Table 3. Thermal data**

| Symbol                | Parameter                           | Value                             |        | Unit |
|-----------------------|-------------------------------------|-----------------------------------|--------|------|
|                       |                                     | TO-220FP,<br>I <sup>2</sup> PAKFP | TO-3PF |      |
| R <sub>thj-case</sub> | Thermal resistance junction-case    | 3.13                              | 2.00   | °C/W |
| R <sub>thj-amb</sub>  | Thermal resistance junction-ambient | 62.5                              | 50     | °C/W |

**Table 4. Avalanche characteristics**

| Symbol          | Parameter   | Value | Unit |
|-----------------|---|-------|------|
| I <sub>AR</sub> | Avalanche current, repetitive or not repetitive (pulse width limited by T <sub>jmax</sub> )                             | 6     | A    |
| E <sub>AS</sub> | Single pulse avalanche energy (starting T <sub>j</sub> =25°C, I <sub>D</sub> = I <sub>AR</sub> ; V <sub>DD</sub> =50 V) | 500   | mJ   |

## 2 Electrical characteristics

( $T_C = 25\text{ °C}$  unless otherwise specified)

**Table 5. On /off states**

| Symbol        | Parameter                           | Test conditions  | Min. | Typ.  | Max.     | Unit          |
|---------------|-------------------------------------|--|------|-------|----------|---------------|
| $V_{(BR)DSS}$ | Drain-source breakdown voltage      | $V_{GS} = 0, I_D = 1\text{ mA}$                                | 600  |       |          | V             |
| $I_{DSS}$     | Zero gate voltage drain current ( ) | $V_{GS} = 0, V_{DS} = 600\text{ V}$                            |      |       | 1        | $\mu\text{A}$ |
|               |                                     | $V_{GS} = 0, V_{DS} = 600\text{ V}, T_C = 125\text{ °C}^{(1)}$ |      |       | 100      | $\mu\text{A}$ |
| $I_{GSS}$     | Gate-body leakage current           | $V_{DS} = 0, V_{GS} = \pm 25\text{ V}$                         |      |       | $\pm 10$ | $\mu\text{A}$ |
| $V_{GS(th)}$  | Gate threshold voltage              | $V_{DS} = V_{GS}, I_D = 250\text{ }\mu\text{A}$                | 2    | 3     | 4        | V             |
| $R_{DS(on)}$  | Static drain-source on-resistance   | $V_{GS} = 10\text{ V}, I_D = 17\text{ A}$                      |      | 0.078 | 0.088    | $\Omega$      |

1. Defined by design, not subject to production test

**Table 6. Dynamic**

| Symbol                     | Parameter                     | Test conditions  | Min. | Typ. | Max. | Unit     |
|----------------------------|-------------------------------|--|------|------|------|----------|
| $C_{iss}$                  | Input capacitance             | $V_{GS} = 0, V_{DS} = 100\text{ V}, f = 1\text{ MHz}$  | -    | 2500 | -    | pF       |
| $C_{oss}$                  | Output capacitance            |  | -    | 117  | -    | pF       |
| $C_{rss}$                  | Reverse transfer capacitance  |  | -    | 2.4  | -    | pF       |
| $C_{oss\text{ eq.}}^{(1)}$ | Equivalent output capacitance | $V_{GS} = 0, V_{DS} = 0\text{ to }480\text{ V}$  | -    | 342  | -    | pF       |
| $R_G$                      | Intrinsic gate resistance     | $f = 1\text{ MHz}, I_D = 0$  | -    | 4.4  | -    | $\Omega$ |
| $Q_g$                      | Total gate charge             | $V_{DD} = 480\text{ V}, I_D = 34\text{ A}, V_{GS} = 10\text{ V}$<br>(see <a href="#">Figure 17: Gate charge test circuit</a> ) | -    | 57   | -    | nC       |
| $Q_{gs}$                   | Gate-source charge            |  | -    | 10   | -    | nC       |
| $Q_{gd}$                   | Gate-drain charge             |  | -    | 25.5 | -    | nC       |

1.  $C_{oss\text{ eq.}}$  is defined as a constant equivalent capacitance giving the same charging time as  $C_{oss}$  when  $V_{DS}$  increases from 0 to 80%  $V_{DSS}$

Table 7. Switching times

| Symbol       | Parameter           | Test conditions   | Min. | Typ. | Max. | Unit |
|--------------|---------------------|---|------|------|------|------|
| $t_{d(on)}$  | Turn-on delay time  | $V_{DD} = 300\text{ V}$ , $I_D = 34\text{ A}$ ,<br>$R_G = 4.7\ \Omega$ , $V_{GS} = 10\text{ V}$<br>(see <a href="#">Figure 16: Switching times test circuit for resistive load</a> and <a href="#">Figure 21: Switching time waveform</a> ) | -    | 20.5 | -    | ns   |
| $t_r$        | Rise time           |   | -    | 13.5 | -    | ns   |
| $t_{d(off)}$ | Turn-off-delay time |   | -    | 96   | -    | ns   |
| $t_f$        | Fall time           |   | -    | 11   | -    | ns   |

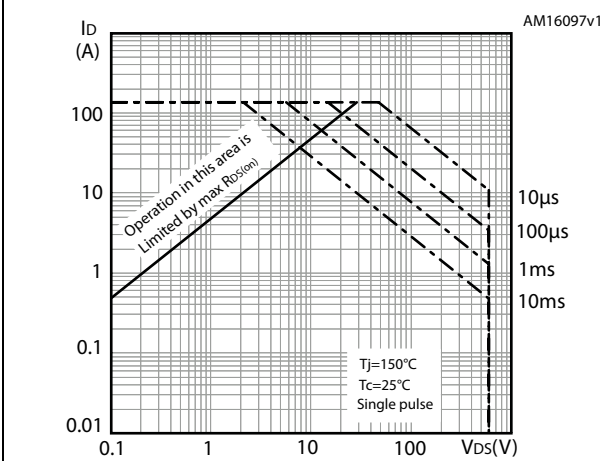
Table 8. Source drain diode

| Symbol          | Parameter                     | Test conditions   | Min. | Typ. | Max. | Unit          |
|-----------------|-------------------------------|---|------|------|------|---------------|
| $I_{SD}$        | Source-drain current          |   | -    | 34   |      | A             |
| $I_{SDM}^{(1)}$ | Source-drain current (pulsed) |   | -    | 136  |      | A             |
| $V_{SD}^{(2)}$  | Forward on voltage            | $I_{SD} = 34\text{ A}$ , $V_{GS} = 0$   | -    |      | 1.6  | V             |
| $t_{rr}$        | Reverse recovery time         | $I_{SD} = 34\text{ A}$ , $di/dt = 100\text{ A}/\mu\text{s}$<br>$V_{DD} = 60\text{ V}$ (see <a href="#">Figure 18: Test circuit for inductive load switching and diode recovery times</a> )  | -    | 440  |      | ns            |
| $Q_{rr}$        | Reverse recovery charge       |   | -    | 8.2  |      | $\mu\text{C}$ |
| $I_{RRM}$       | Reverse recovery current      |   | -    | 37   |      | A             |
| $t_{rr}$        | Reverse recovery time         | $I_{SD} = 34\text{ A}$ , $di/dt = 100\text{ A}/\mu\text{s}$<br>$V_{DD} = 60\text{ V}$ , $T_j = 150\text{ }^\circ\text{C}$<br>(see <a href="#">Figure 18: Test circuit for inductive load switching and diode recovery times</a> ) | -    | 568  |      | ns            |
| $Q_{rr}$        | Reverse recovery charge       |   | -    | 11.5 |      | $\mu\text{C}$ |
| $I_{RRM}$       | Reverse recovery current      |   | -    | 40.5 |      | A             |

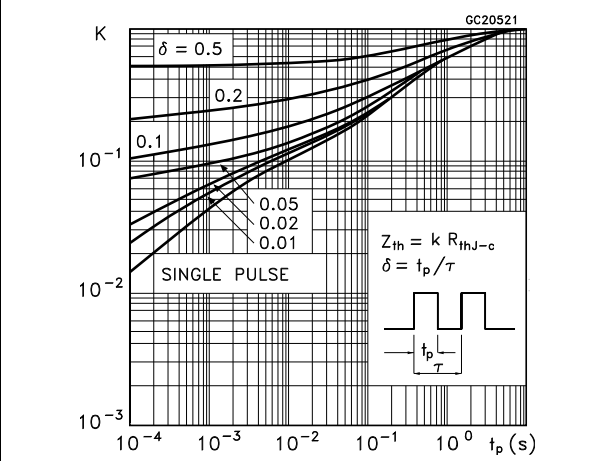
1. Pulse width limited by safe operating area.
2. Pulsed: pulse duration = 300  $\mu\text{s}$ , duty cycle 1.5%

## 2.1 Electrical characteristics (curves)

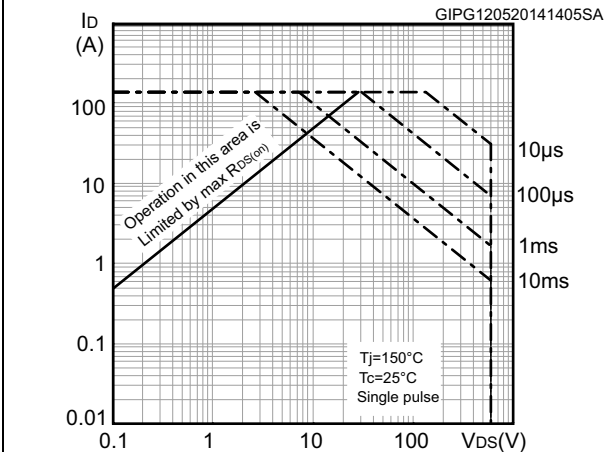
**Figure 2. Safe operating area for TO-220FP and I<sup>2</sup>PAKFP**



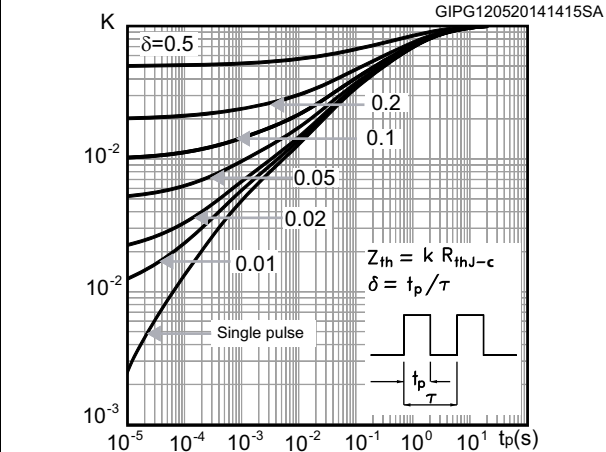
**Figure 3. Thermal impedance for TO-220FP and I<sup>2</sup>PAKFP**



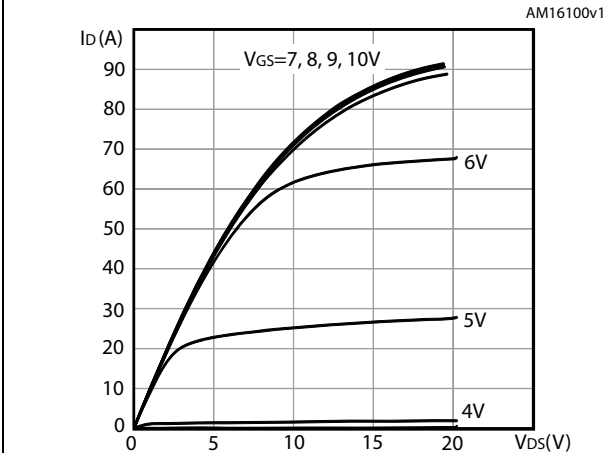
**Figure 4. Safe operating area for TO-3PF**



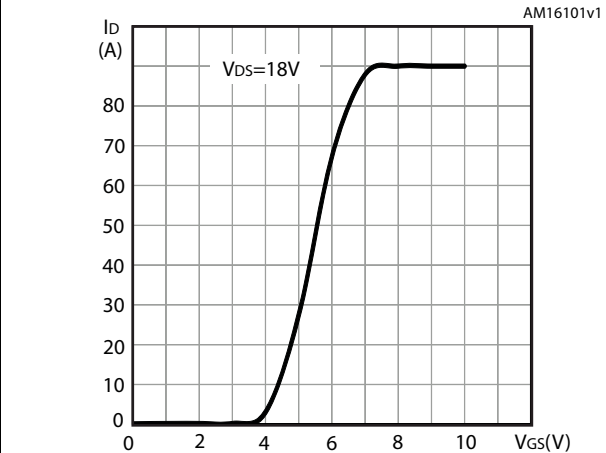
**Figure 5. Thermal impedance for TO-3PF**



**Figure 6. Output characteristics**



**Figure 7. Transfer characteristics**



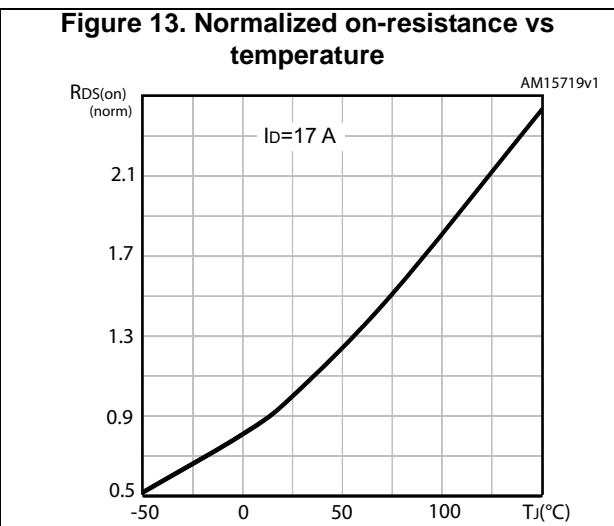
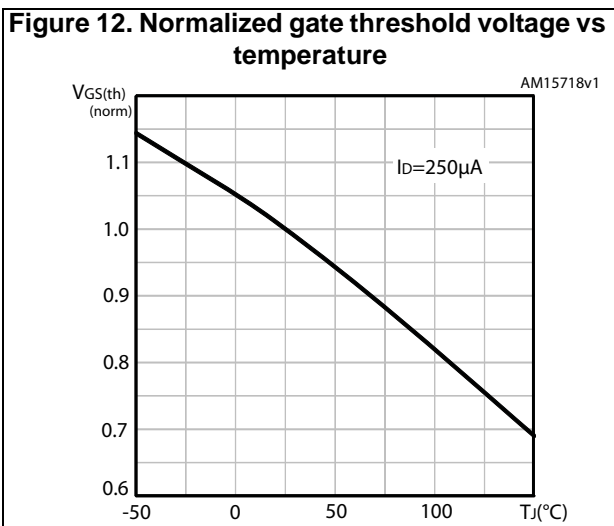
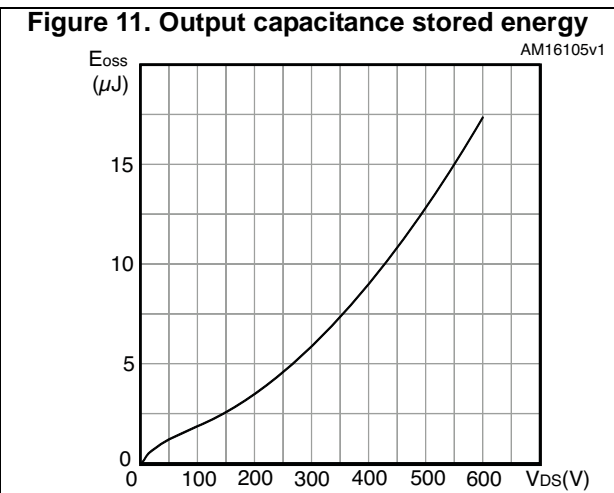
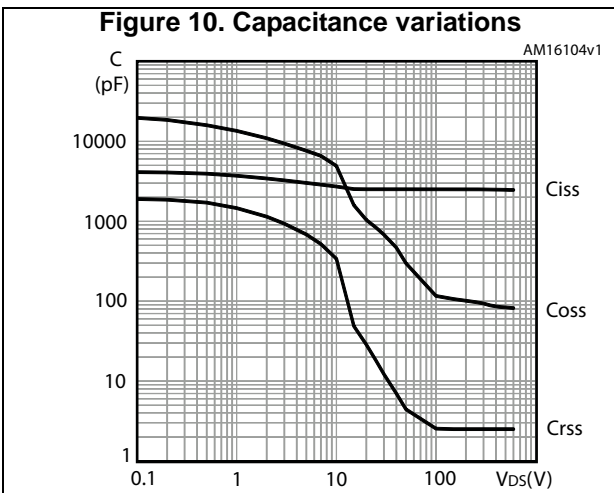
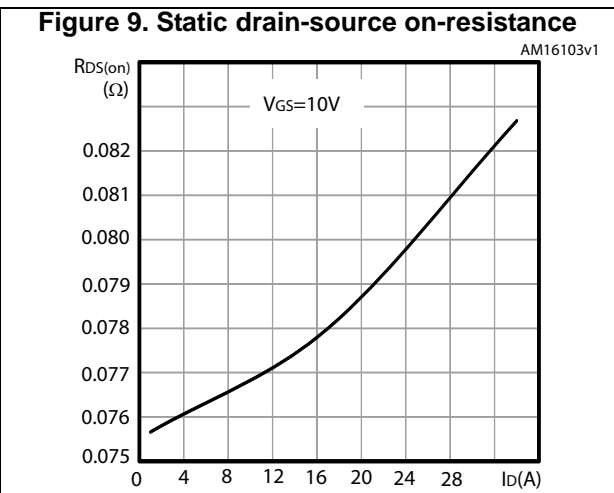
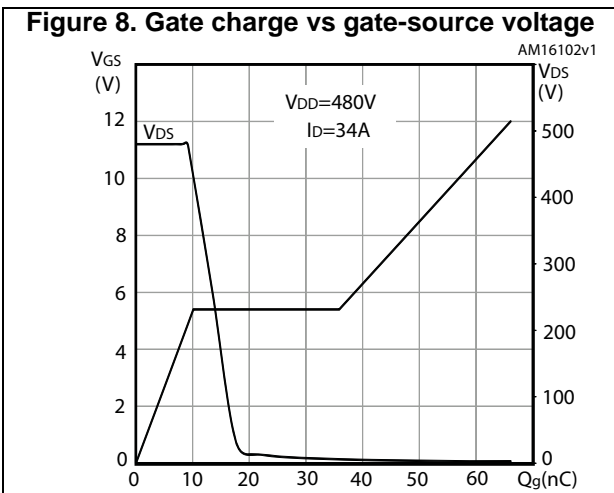


Figure 14. Normalized  $V_{(BR)DSS}$  vs temperature

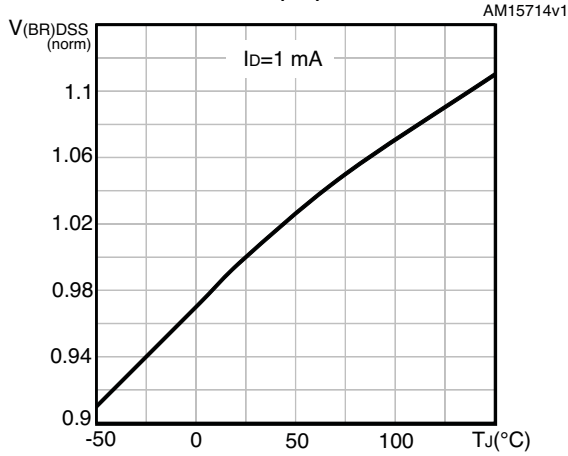
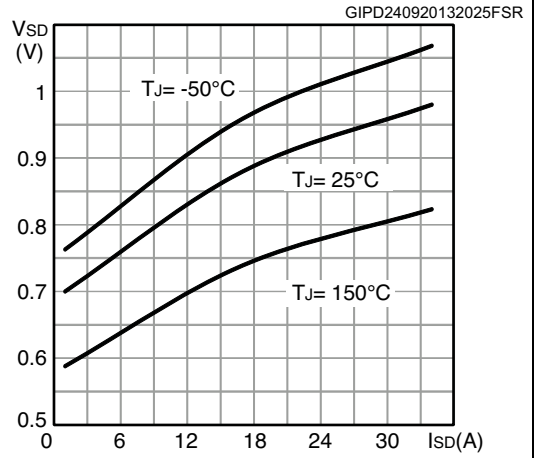
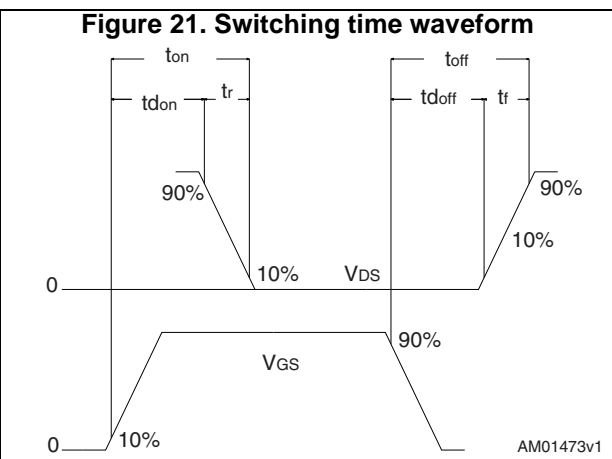
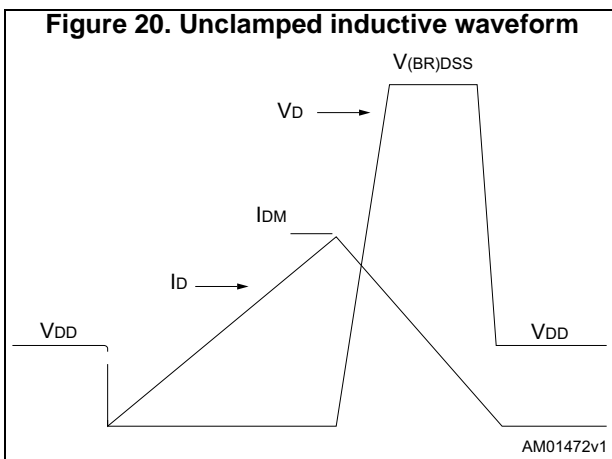
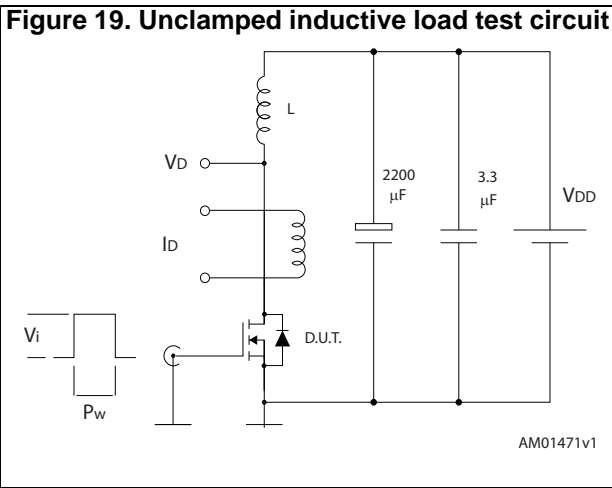
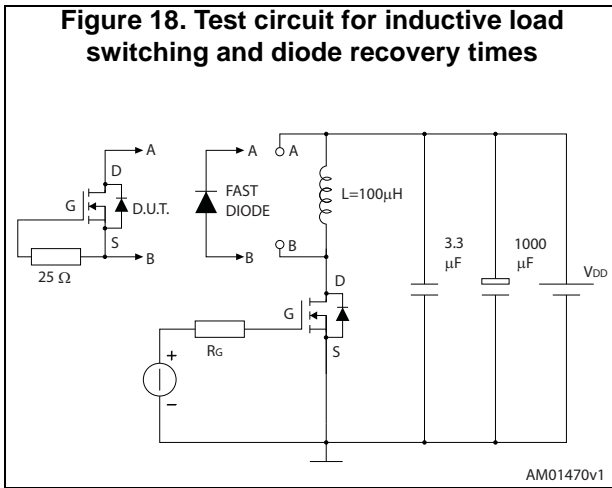
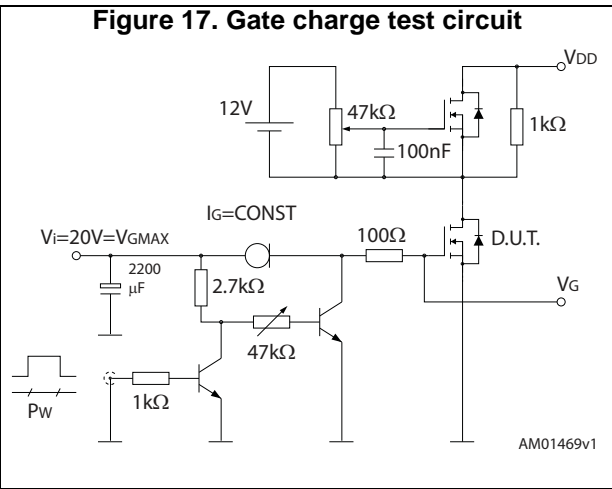
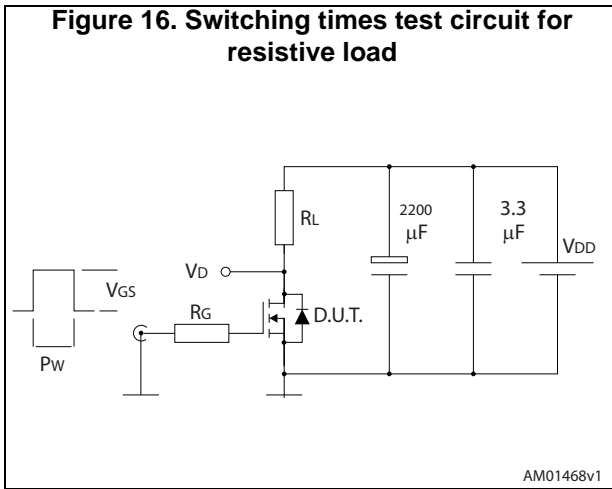


Figure 15. Source-drain diode forward vs temperature





### 3 Test circuits

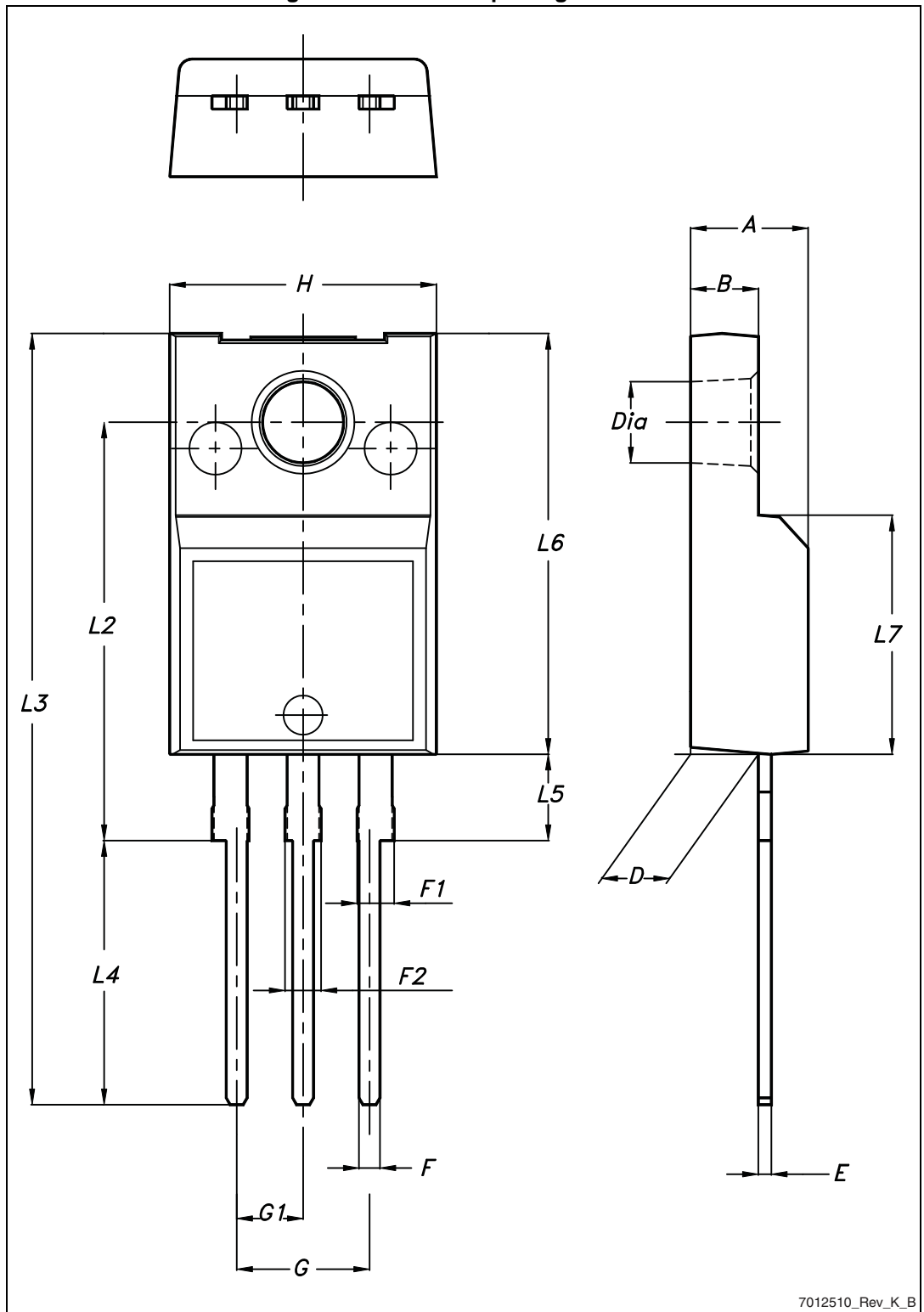


## 4 Package information

In order to meet environmental requirements, ST offers these devices in different grades of ECOPACK<sup>®</sup> packages, depending on their level of environmental compliance. ECOPACK<sup>®</sup> specifications, grade definitions and product status are available at: [www.st.com](http://www.st.com). ECOPACK<sup>®</sup> is an ST trademark.

4.1 TO-220FP, package outline

Figure 22. TO-220FP package outline



7012510\_Rev\_K\_B

Table 9. TO-220FP mechanical data

| Dim. | mm   |      |      |
|------|------|------|------|
|      | Min. | Typ. | Max. |
| A    | 4.4  |      | 4.6  |
| B    | 2.5  |      | 2.7  |
| D    | 2.5  |      | 2.75 |
| E    | 0.45 |      | 0.7  |
| F    | 0.75 |      | 1    |
| F1   | 1.15 |      | 1.70 |
| F2   | 1.15 |      | 1.70 |
| G    | 4.95 |      | 5.2  |
| G1   | 2.4  |      | 2.7  |
| H    | 10   |      | 10.4 |
| L2   |      | 16   |      |
| L3   | 28.6 |      | 30.6 |
| L4   | 9.8  |      | 10.6 |
| L5   | 2.9  |      | 3.6  |
| L6   | 15.9 |      | 16.4 |
| L7   | 9    |      | 9.3  |
| Dia  | 3    |      | 3.2  |

### 4.2 I<sup>2</sup>PAKFP (TO-281) package information

Figure 23. I<sup>2</sup>PAK(TO-281) package outline

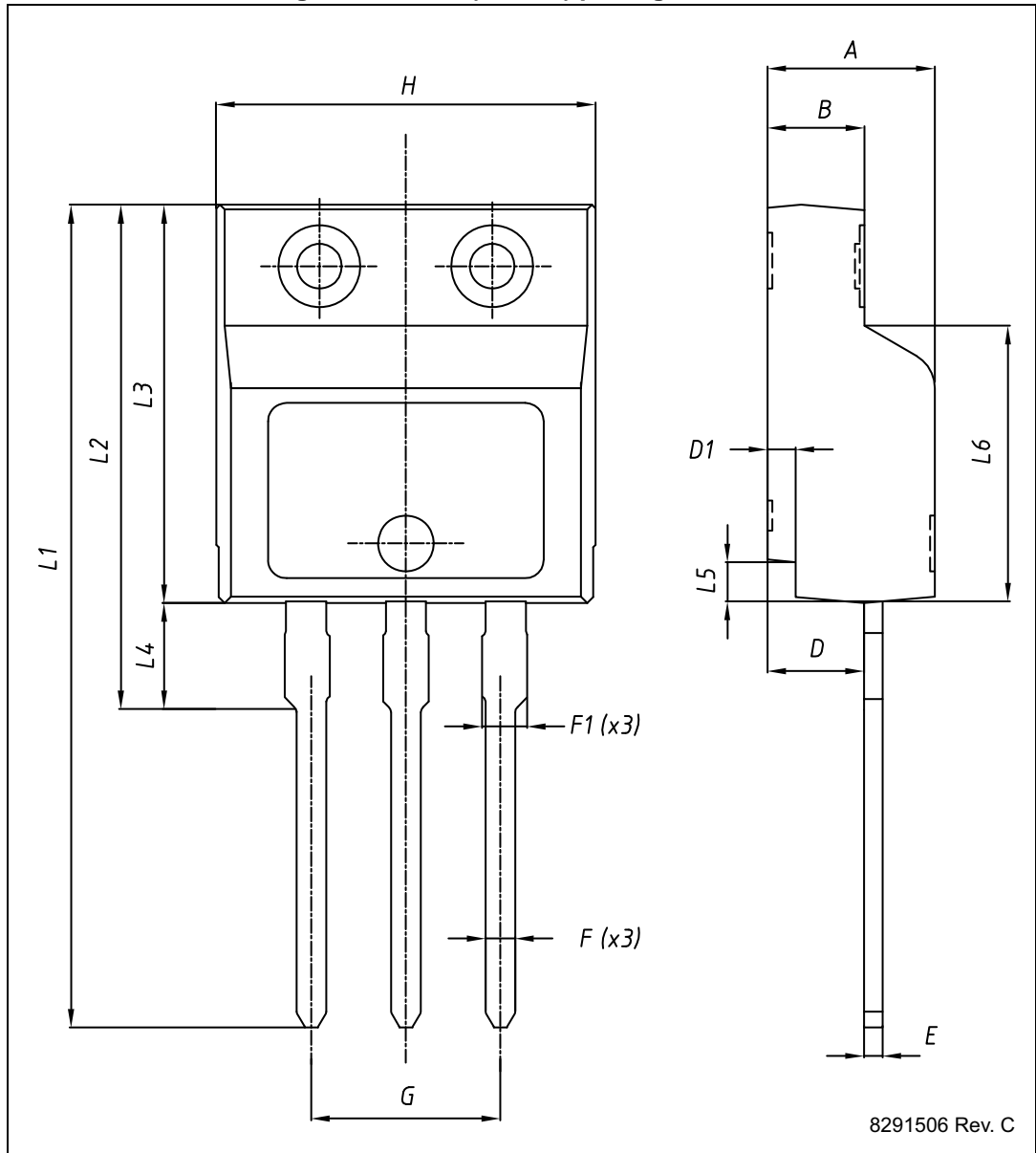
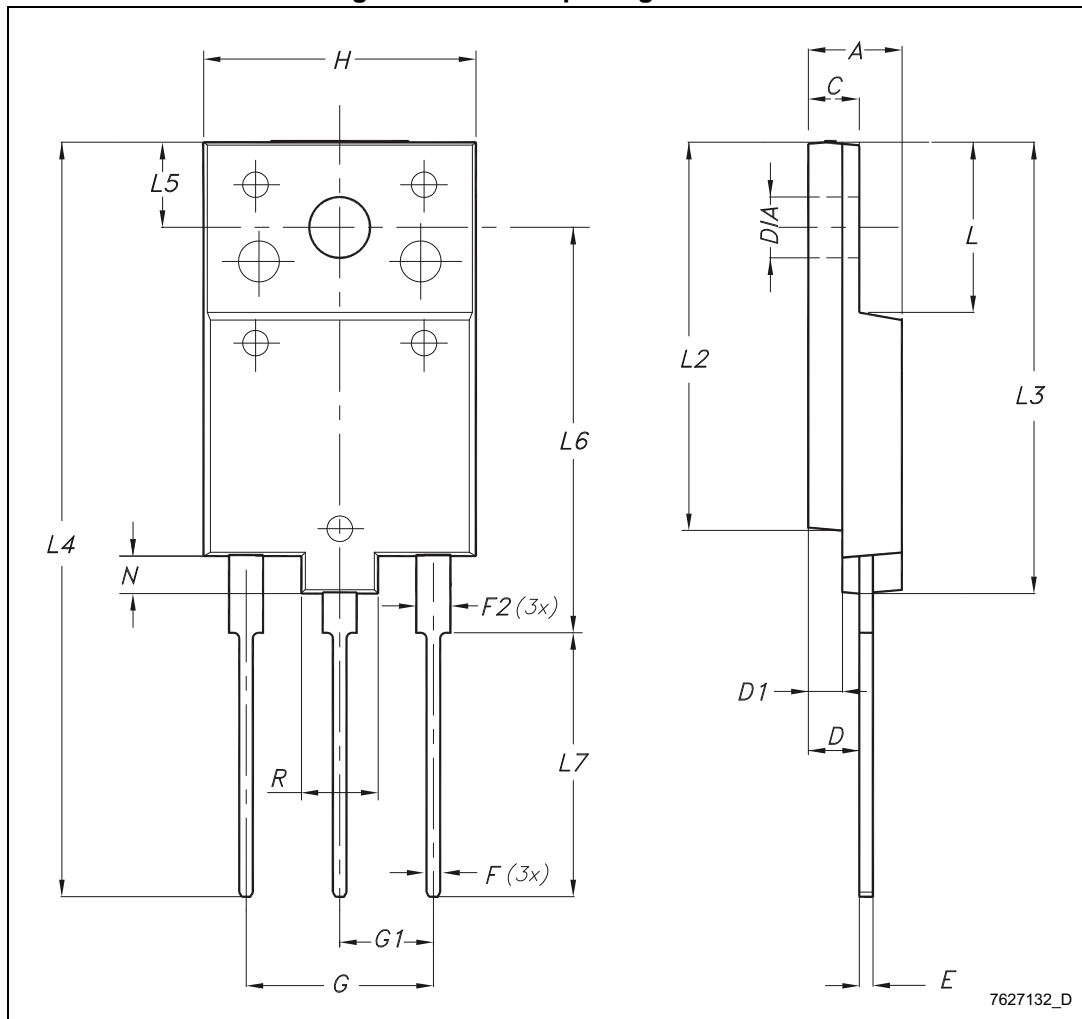


Table 10. I<sup>2</sup>PAKFP (TO-281) package mechanical data

| Dim. | mm    |      |       |
|------|-------|------|-------|
|      | Min.  | Typ. | Max.  |
| A    | 4.40  | -    | 4.60  |
| B    | 2.50  |      | 2.70  |
| D    | 2.50  |      | 2.75  |
| D1   | 0.65  |      | 0.85  |
| E    | 0.45  |      | 0.70  |
| F    | 0.75  |      | 1.00  |
| F1   |       |      | 1.20  |
| G    | 4.95  |      | 5.20  |
| H    | 10.00 |      | 10.40 |
| L1   | 21.00 |      | 23.00 |
| L2   | 13.20 |      | 14.10 |
| L3   | 10.55 |      | 10.85 |
| L4   | 2.70  |      | 3.20  |
| L5   | 0.85  |      | 1.25  |
| L6   | 7.50  | 7.60 | 7.70  |

### 4.3 TO-3PF, package information

Figure 24. TO-3PF package outline



7627132\_D

Table 11. TO-3PF package mechanical data

| Dim. | mm    |      |       |
|------|-------|------|-------|
|      | Min.  | Typ. | Max.  |
| A    | 5.30  |      | 5.70  |
| C    | 2.80  |      | 3.20  |
| D    | 3.10  |      | 3.50  |
| D1   | 1.80  |      | 2.20  |
| E    | 0.80  |      | 1.10  |
| F    | 0.65  |      | 0.95  |
| F2   | 1.80  |      | 2.20  |
| G    | 10.30 |      | 11.50 |
| G1   |       | 5.45 |       |
| H    | 15.30 |      | 15.70 |
| L    | 9.80  | 10   | 10.20 |
| L2   | 22.80 |      | 23.20 |
| L3   | 26.30 |      | 26.70 |
| L4   | 43.20 |      | 44.40 |
| L5   | 4.30  |      | 4.70  |
| L6   | 24.30 |      | 24.70 |
| L7   | 14.60 |      | 15    |
| N    | 1.80  |      | 2.20  |
| R    | 3.80  |      | 4.20  |
| Dia  | 3.40  |      | 3.80  |



## 5 Revision history

**Table 12. Document revision history**

| Date        | Revision | Changes   |
|-------------|----------|---|
| 15-May-2014 | 1        | First release. Part numbers STF40N60M2 and STFI40N60M2 previously included in datasheet DocID024932.  |
| 28-Sep-2016 | 2        | Updated title in cover page.<br>Updated <a href="#">Table 2: Absolute maximum ratings</a> , <a href="#">Table 5: On /off states</a> , <a href="#">Table 6: Dynamic</a> and <a href="#">Table 8: Source drain diode</a> .<br>Minor text changes. |

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